#### TE11P-0001-0116

# DESIGN OBJECTIVES UNSEAL 24WAY/20WAY CONNECTOR, 108-101431

The product described in this document has not been fully tested to ensure conformance to the requirements outlined herein. TE Connectivity makes no representation or warranty, express or implied that the product will comply with these requirements. Further, TE Connectivity reserves the right these requirements based on the results of additional testing and evaluation. Contact TE Connectivity Engineering for further information. If necessary, This document will become the Product Specification at successful completion of testing.

### 1. Scope:

### 1.1 Content

This specification covers the requirements for product performance, test methods and quality assurance provisions of 24 & 20 WAY UNSEALED IN-LINE connector.

24WAY REC PLUG : \*-2298622-\*, Consists of 2298623-\*, \*-2298626-\* 24WAY TAB PLUG : \*-2298627-\*, Consists of 2298629-1, \*-2298630-\* 20WAY REC PLUG : \*2298671-\*. Consists of 2302509-\* 2302504-1 20WAY TAB PLUG : \*2298672-\* Consists of 2302512-\*, 2302504-1

### 1.2 Qualification

When tests are performed on the subject product line, the procedures specified in TE Connectivity 109 series specifications shall be used. All inspections shall be performed using the applicable Inspection Plan and Product Drawing.

### 2. Applicable Documents:

The following documents form a part of this Specification to the extent specified herein. In the event of conflict between the requirements of this Specification and the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

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2.1 TE Connectivity Specifications:

A. 109 SERIES: Test Specification, Requirements for Test Methods.B. VW LV 214C. USCAR2-2013

# 3. Requirements:

- 3.1 Design and Construction Product shall be of the design, construction and physical dimensions specified in the applicable product drawing.
- 3.2 Materials

Description for material see in product drawing.

3.3 Ratings:

Operating temperature Range : -40  $^{\circ}$ C to + 125  $^{\circ}$ C

3.4 Performance and Test Descriptions

The product is designed to meet the electrical, mechanical and environmental performance requirements specified in paragraph 3.5 All tests are performed at ambient environmental conditions per VW LV214 unless otherwise specified

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# 3.5 Requirements and Procedures Summary

### MECHANICAL TEST

Para.	Test items	Requirements		Procedures					
3.5.1	Visual inspection	No damage		Acc. DIN EN 60512-1-1					
3.5.2	Drop test	Samples all meet the 3 all the components in corrected positon	.5.1;	Acc. USCAR-2 5.4.8 Samples from testing X, Y and Z axis orientation					
3.5.3	Actuation forces for secondary lock	Open force Fo=10N~5 Close force Fs<50N	Fo=10N~50N Fs<50N Fs<50N Apply lock po housin Apply to pre- unequi			Acc. LV214 2010-03 PG6 E6.4 Apply axial load to secondary lock, engage to lock position from pre-lock position, un-equiped housings. Apply axial load to secondary lock , disengage to pre-lock position from lock position, unequipped housings.			
3.5.4	Polarizing/Key- ing	Keying/Polarizing efficiency>3 times the insertion force(equippe housing),but at least : 24way : 150N 20way : 130N	ed	Error-p axial lo hsg. Co Error-p housin	Error-proof design of housings (Polarizing), applying axial load to housings, plug hsg, coding "A" of cap nsg. Coding " B", housings unequipped, initial parts Error-proof design of housings(unequipped nousings)				
3.5.5	Retention force of the housing latch/lock	The retention force must>100N at 1mm		Acc. LV214 2010-03 E7.2 DIN EN 60512-15-6 Apply axial load to housings, unequipped housings, Test speed: 50mm/min					
3.5.6	Connector- Connector mating force	The mating force 24 way <150N 20way <130N		Applyir housin Test sp	ng axial load to h gs. beed =50mm/mir	ousings, ur 1.	nequipped		
3.5.7	Determination of the contact insertion forces	The insertion force mu be measured and documented.	The insertion force must be measured and locumented.		Acc. LV214 2010-03 E8.1 Apply axial load to contact Test speed: 50mm/min				
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Para.	Test items	Requirements	Procedures
3.5.8	Contact removal force from the housing, primary lock only	Primary lock test displacement: F prim>40N for MQS0.64; F prim>40N for MCON1.2CB; F prim>60N for MCP2.8K	Acc. USCAR2-2013 5.4.1 Apply axial load to contact, pull or push contact away from hsgs. Test speed: 50mm/min.
3.5.9	Contact removal force from the housing, secondary lock &Primary lock	for MQS0.64 F>60N for MCON1.2CB F >70N for MCP2.8K F>100N	Acc. USCAR2-2013 5.4.1 Apply axial load to contact, pull or push contact away from hsgs. Test speed: 50mm/min.
3.5.10	Clip mount & retention force	Mount force <80N Retention force >110N	Push speed: 50mm/min
		ENVIRONMENT	TAL TEST
3.5.11	Derating with housing	Acc. LV214 PG13 E13.2	Acc. LV214 PG 13 E13.2
3.5.12	Contact resistance	Initial   MQS: $0.35mm2 \ 10m\Omega$ MCON1.2: $0.5 \ 0.75mm2$ 10 mΩ   MCP2.8 2.5mm2 5mΩ   4.0mm2 5mΩ   After environment   MQS: $0.35mm2 \ 15m\Omega$ MCON1.2: $0.5 \ 0.75mm2$ MQS: $0.35mm2 \ 15m\Omega$ MCON1.2: $0.5 \ 0.75mm2$ 15mΩ   MCP2.8 2.5mm2 \ 10mΩ   4.0mm2 \ 5mΩ	Acc. USCAR 5.3.2.4
3.5.13	Contact resistance continuous during dynamic load,broad-band random vibration with test current(100mA)	No function-relevant damage must occur Circuit interruption monitoring takes place during the test. Permissible circuit interruption <1000ns. The circuit considered interrupted when the contact resistance exceeds 7 $\Omega$ . Interruptions are not permissible.	Acc. LV214 PG 17 E14.0 DIN EN 60068-2-64 Measurement frequency: 1 measured value per min Severity: see below table $\frac{10^{10} \text{Body}^{4}}{10^{10} \text{Body}^{10}} = 0 \frac{10 \text{ min}/20^{10} \text{C}}{150 \text{ min}/40^{10} \text{C}} = 0 \frac{1000 \text{ min}/20^{10} \text{C}}{125 \frac{100}{100} \frac{1000}{125} \frac{1000}{125} \frac{1000}{125} \frac{1000}{125} \frac{1000}{125} \frac{1000}{1000} \frac{1000}{125} \frac{1000}{1000} \frac$

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Para.	Test items	Requirements	Procedures
3.5.14	Contact resistance continuous during endurance shock test with test current (100mA)	No function-relevant damage must occur Circuit interruption monitoring takes place during the test. Permissible circuit interruption <1000ns. The circuit considered interrupted when the contact resistance exceeds 7 $\Omega$ . Interruptions are not permissible.	$ \begin{array}{c c} Acc. \ LV214 \ PG \ 17 \ E14.0 \\ \hline DIN \ EN \ 60068-2-27 \\ \hline Severity: \ see \ below \ table \\ \hline \\ $
3.5.15	Long-term aging in dry heat		Acc. DIN EN 60068-2-2 Test B Duration: 1000h Temperature: 130°C Subsequent aging: 48h at RT
3.5.16	Functional test	There must be no functional impairments detected on the housing. Cracking or delamination that affect the function are not permissible. Contact resistance: Comply with below table MQS: $0.35mm2 \ 15m\Omega$ MCON1.2: $0.5 \ 0.75mm2$ $15m\Omega$ MCP2.8 $2.5mm2 \ 10m\Omega$ $4.0mm2 \ 5m\Omega$ Contact pull-out force must comply with below: for MQS0.64, MCON1.2CB F >55N for MCP2.8K F>80N	Acc.USCAR 5.3.2.4
3.5.17	Resistance to agents	No functionally significant structural or dimensional change Insulation resistance>100 M Ω The DUT must remain fully functional	DUTs must be exposed to the fluids and aged for 48h at the required aging temperature. For chemical and method, see Appendix A

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		SAMF	PLE QUAN	TITIES				
	TEST GROUPS							
	1	2	3	4	5			
Test or	24way:(3	24way:(8	24way:(16F	24way:(16	24way:(16M			
examination	F+3M)	F+8M)	+16M)	F+16M)	)			
	20way(3F	20way(8F	20way(16F+	20way(16F	20way(4M)			
	+3M)	+4M)	16M)	+8M)				
3.5.1 Visual inspection	1,3	1	1,5	1,5	1			
3.5.2 Drop test	2							
3.5.3 Actuation forces for secondary lock		2						
3.5.4 Polarizing/Keying			2					
3.5.5 Retention force of the housing latch/lock			3					
3.5.6 Connector-Connector mating force			4					
3.5.7 Determination of the contact insertion forces				2				
3.5.8 Contact removal force from the housing, primary lock only				3				
3.5.9 Contact removal force from the housing, secondary &Primary lock				4				
3.5.10 clip mount & retention force					2			

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SAMPLE QUANTITIES										
	T	TEST GROUPS( Environment Test)								
	6	7	8	9						
Test or examination	24way:(2F +2M)	24way:(3 F+3M)	24way:(2F+ 2M)	24way:(5F+5M						
	20way (2F+	20way(5F	20way(2F+2	) 20way(5F+5M)						
3.5.1 Visual inspection	2M)	+5M)	M)							
	1,3	1,4,7	1,3	1,7						
3.5.9 Contact removal force from the housing, secondary &Primary lock				6						
3.5.11 Derating with housing	2									
3.5.12 Contact resistance		2,6		2,4						
3.5.13 Contact resistance continuous during dynamic load, broad-band random vibration with test current(100mA)		3								
3.5.14 Contact resistance continuous during endurance shock test with test current (100mA)		5								
3.5.15 Long-term aging in dry heat				3						
3.5.16Functional test				5						
3.5.17 Resistance to agents			2							
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# 4. QUALIFICATION TEST

#### 4.1 Sample selection

Samples shall be prepared in accordance with applicable specification.

#### 4.2 Test sequence

Qualification test shall be conducted as sequence specified in 3.6.

#### 4.3 Requalification test

If changes significantly affecting form, fit or function are made to product or manufacturing process, product assurance shall co-ordinate requalification testing, consisting of all or part of original testing sequence as determined by developments, product, quality and reliability engineering.

### **5. APPENDIX**

			Dous Rubb Spray	ing ing in ⁄ing	At least 100 at least 8 m damp cottor approx. 1 s	ml (accor /cm² surfa n cloth per side	ding to DI ace)	IN EN	ISO 175
No.	PG	Chemical agent	Desc	ription		Applicatio	n		Aging temp. °C
						Rubbing	[]		
	2		0.000		Dousing	in	Spray	ing	48 h
1	22 A	cleaning agent	availa	able			×		50
2	22 A	Penetrating oil	Comr	nercially able			×	11	50
3	22 A	Undiluted washer fluid anti- freeze	Comr	nercially able	x				50
4	22 A	Isopropanol	Comr availa	nercially able	x				RT
5	22 A	Grease	High greas	melting point		x			50
6	22 B	Brake fluid	DOT	4/DOT 5	×				50
7	22 P	FAM test fuel	Comr	mercially					DT
0	22 D	(gasoline/premium)	DINE		X				
0	22 B	Diediagol	DINE	IN 390	X				
0	22 B	Discaled different ad Disc	DINE	20070	X				
8	22 B	Diesel additive AdBlue	DIN /	0070	x				 
9	22 B	Engine oil 5W-30	Fully	synthetic	x		-		50
10	22 B	Power steering fluid	quire	ment	x				50
10	22 B	Automatic transmission fluid	Fully	synthetic	x			2	50
11	22 B	Radiator antifreeze	Stable to -40	e ) °C	x				50
12	22 B	Battery fluid: Relevant only for DUTs that can come into con- tact with battery fluid	Dilute acid; 1,28 d	ed sulfuric density g/ml	x				50
13	22 B	Road salt solution	Mixtu	re PG18C	x				50
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### Appendix A